



Institut d'Electronique du Sud, Group « Energy et Materials »



JICABLE HVDC 13

Perpignan 2013 November 18-20

Electrical Phenomena Modeling In Polyethylene

Alain Toureille , Jerome Castellon , Serge Agnel



Plan

- 1-Introduction
- 2- Thermal Step Method (T.S.M.)
- 3-Influential parameters in PE under DC
- 4- Pure Polarisation and thermo-stimulated current
- 5-Polarisation and Injection
- 6-Strong Injection and Thermal stimulated current
- 7-Conduction
- 8-Conclusion

1-Introduction

- PE structure

Conduction Band : 8-9 eV

Localized levels : from 0.3 to 2.0 eV under CB
and above VB

- Space Charges Measurements
 - Giving evidence of different states: polarization, injection at high electric field and links with conduction, ageing, breakdown...

The Methods of measurements

- The Pressure Waves:
 - LIPP, PEA

The Thermal Waves

-LIMM, TP, FLIMM, FLAMM, TSM, MOTA,

TSM

- -Created in 1986
- Easy to apply and sensitive
- -Applied in numerous solid insulating materials: pure and composites
- -Electrical Engineering: slabs, films, cables
- -Installed in Industries

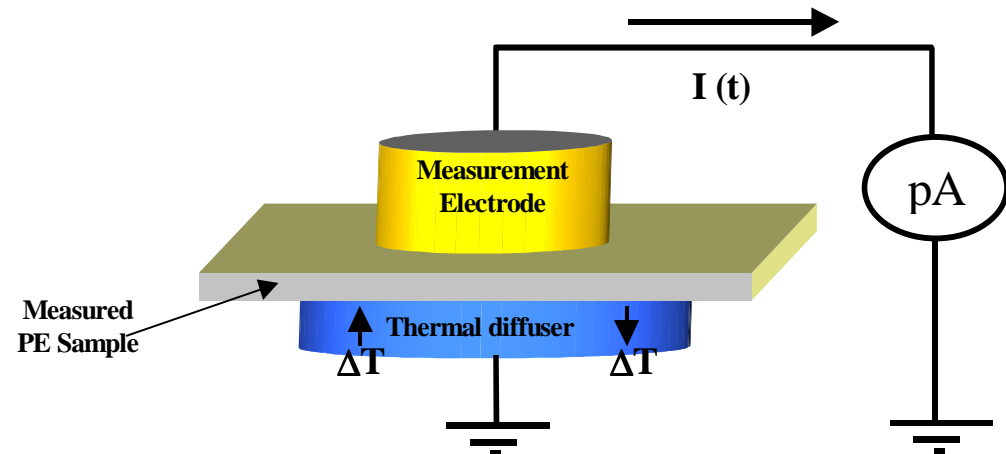
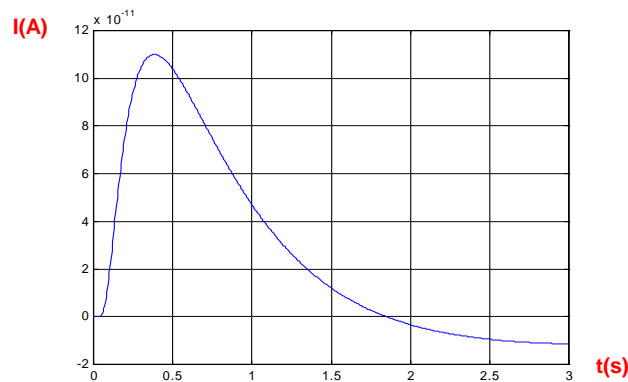
TSM in Short Circuit Conditions

1. Short circuited sample

2. Applying the thermal step

$$dx' = dx(1 + \alpha_x \Delta T)$$

$$\varepsilon' = \varepsilon(1 + \alpha_\varepsilon \Delta T)$$



Balance
changed

Re-balancing

$$I(t) = \frac{\partial Q_1}{\partial t}$$

$$I(t) = -\alpha C \int_0^D E(x) \frac{\partial \Delta T(x,t)}{\partial t} dx$$

$$\rho(x) = \varepsilon \frac{\partial E(x)}{\partial x}$$

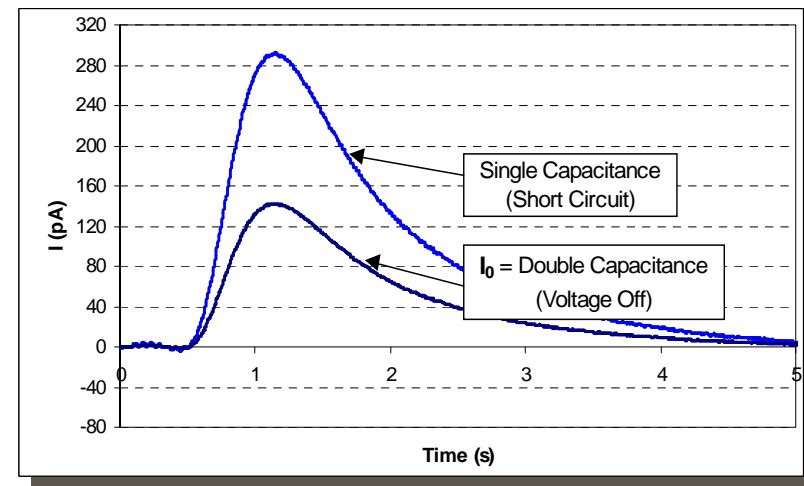
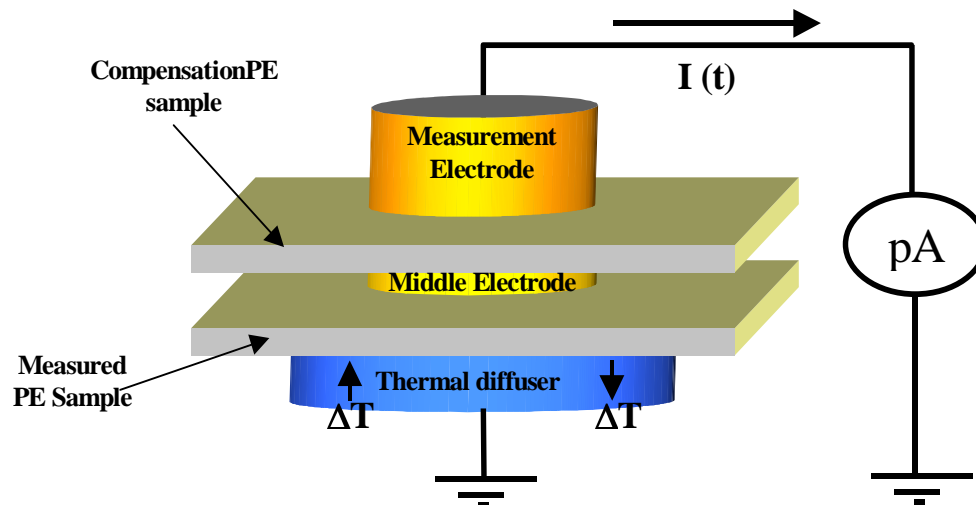
Sample is not discharged = 100% Repeatability



TSM under Applied DC Field

Principle of the “Double Capacitor”

Solution : 2 samples with the same capacitance C



In this case

$$I_{UF}(t) = -\alpha C_2 \int_0^D E(x) \frac{\partial \Delta T(x, t)}{\partial t} dx = \frac{I(t)}{2} \quad \text{with} \quad C_2 = \frac{C}{2}$$

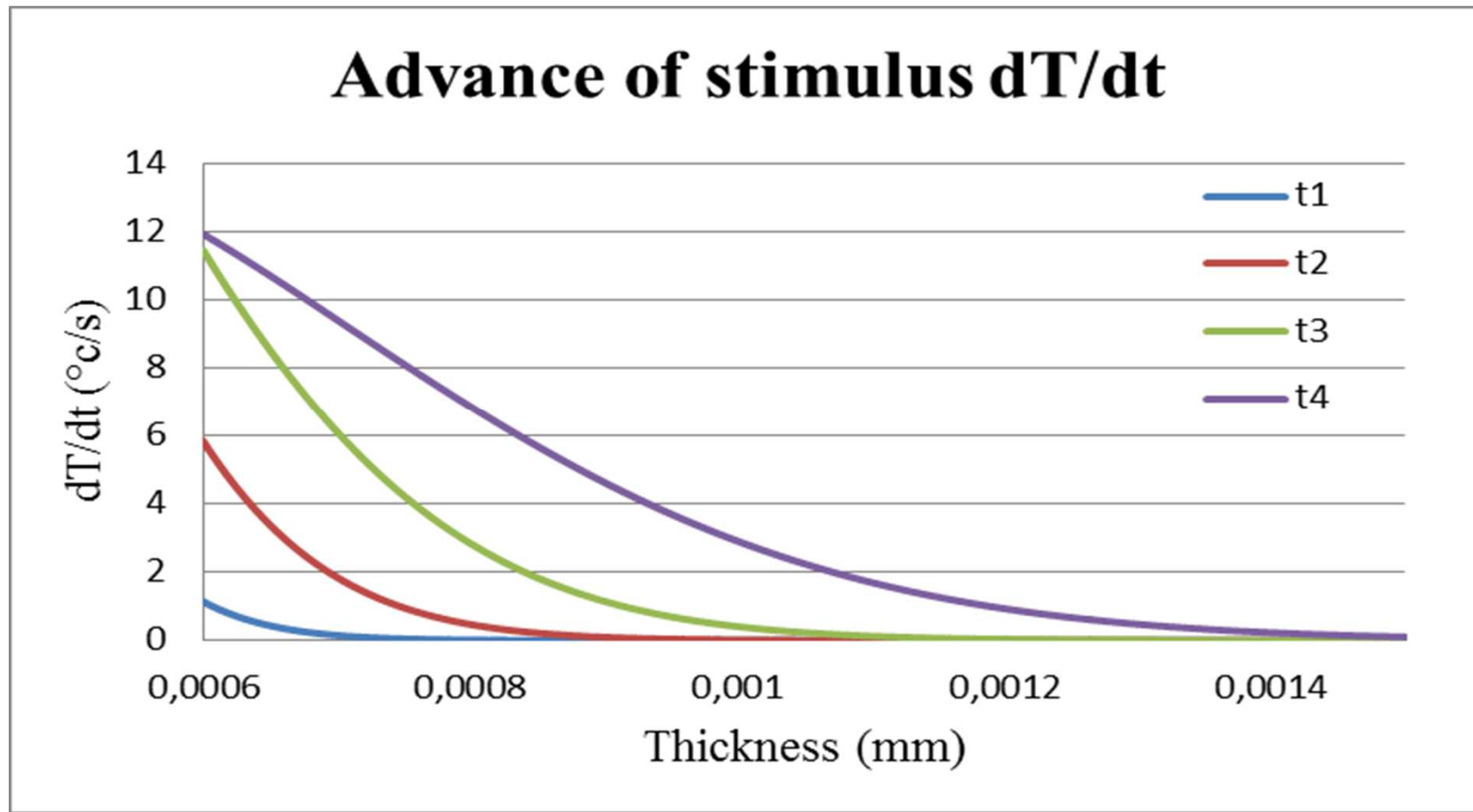
For measuring under field → measurement electrode insulated from the HV source

Numerical Treatment

- Different numerical treatments are used:
- -Derivative of fit current taking account that the stimulus crosses the sample versus time
- - Using odd and even Fourier functions versus the two currents on two faces
- -FFT : the current is a Laplace Transform of Electrical Field : this property proves the unicity of the solution

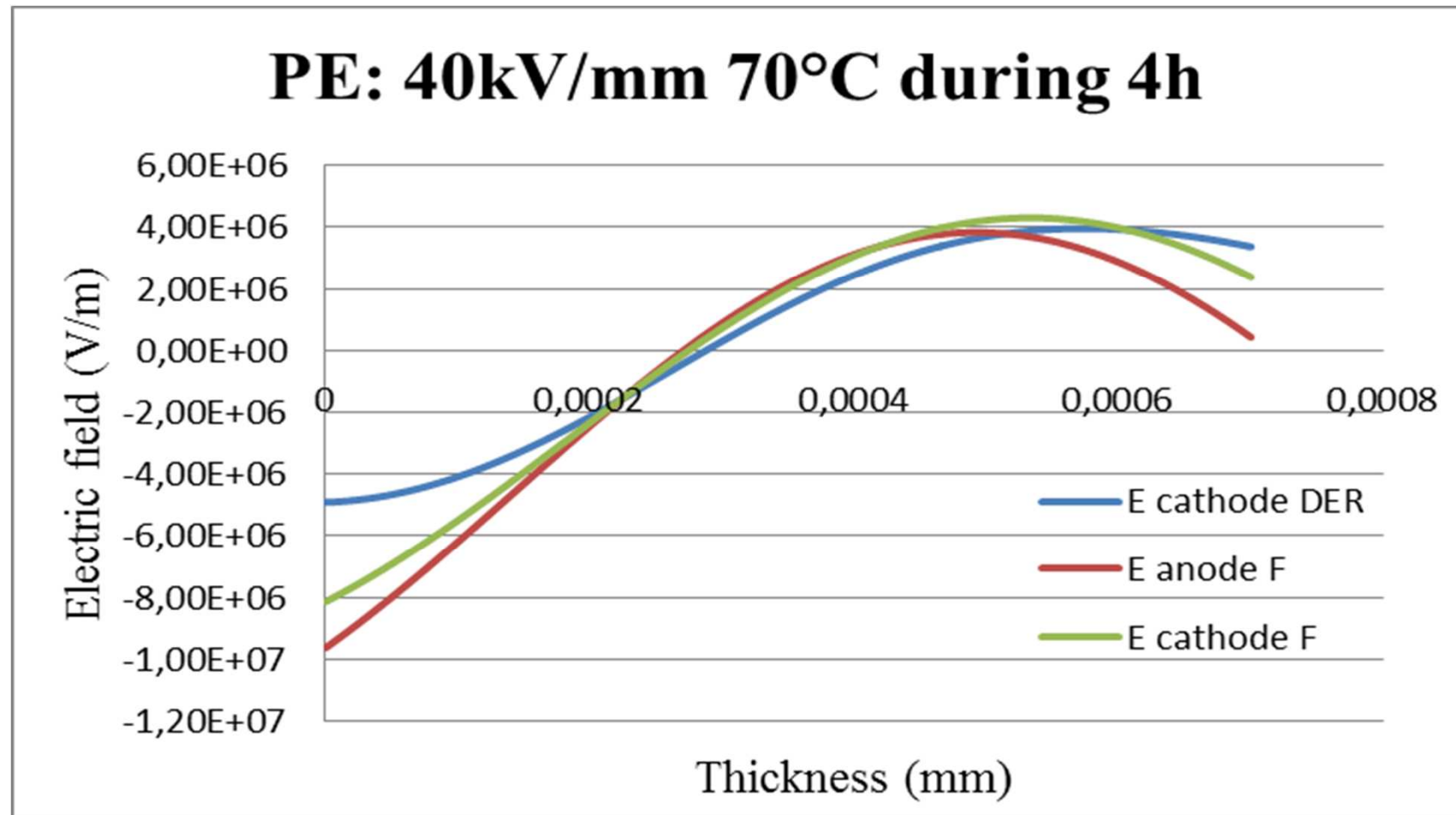


Derivative: dT/dt advanced



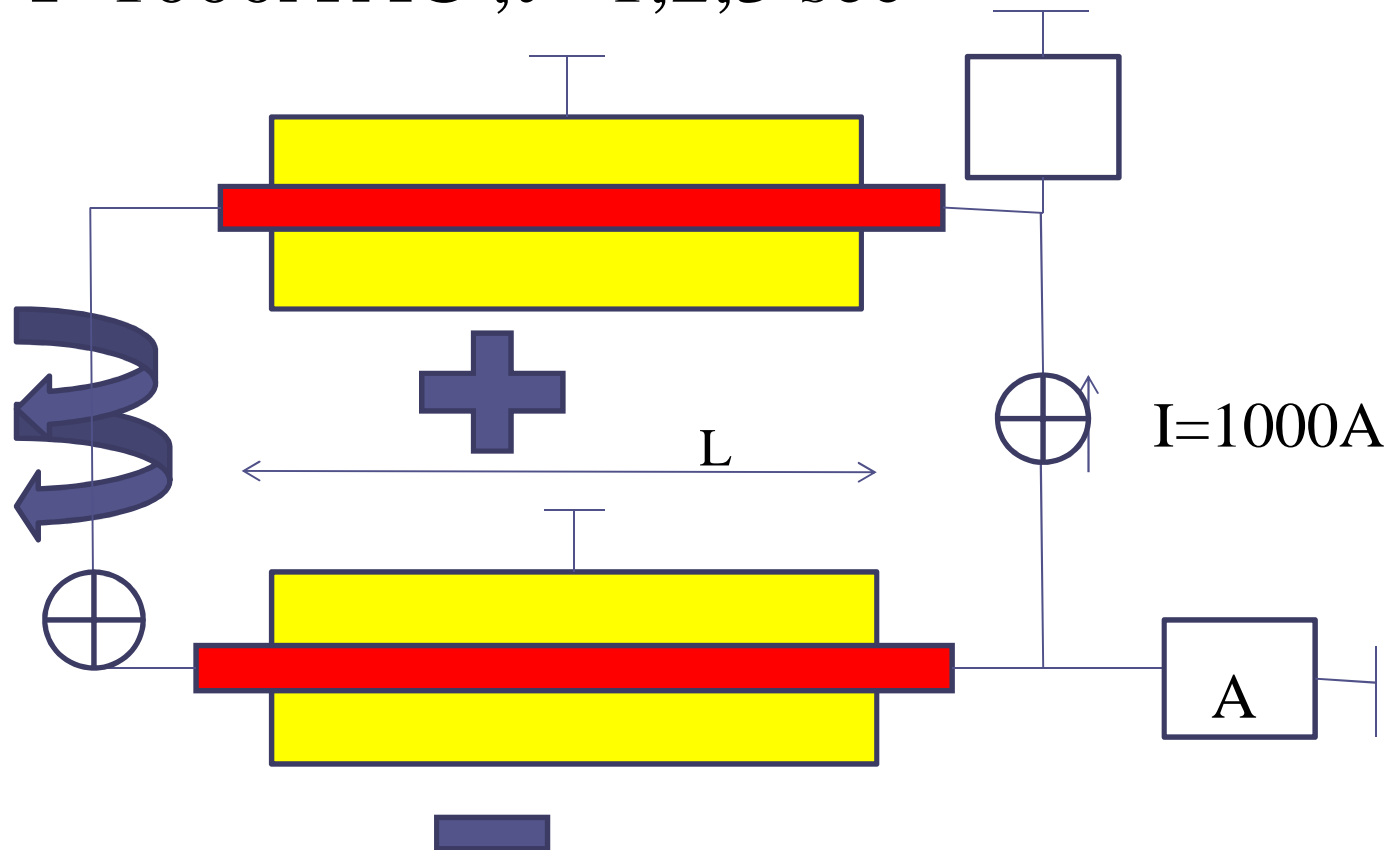


Treatment Comparison



Cable Analysis HVDC + et -

- $I=1000\text{A AC}$, $t= 1,2,3 \text{ sec}$



Effects at the contact

For Schottky effect:

$$J_S = A_S T^2 \exp\left(-\frac{\Phi_0 - \beta_S (\gamma E)^{1/2}}{kT}\right) \quad (4)$$

$$\text{with } A_S = \frac{4\pi q m k^2}{h^3} \text{ and } \beta_S = \sqrt{\frac{q^3}{4\pi\epsilon_0\epsilon_r}}$$

With E = applied electric field ; Φ_0 = energy barrier at the contact, γ : correction factor, γE : real electric field at the contact, T =Temperature.

For Fowler Nordheim effect:

$$J_{FN} = A_{FN} (E_C)^2 \exp\left(-\frac{\beta_{FN}}{E_C}\right) \quad (5)$$

$$\text{with } A_{FN} = \frac{q^3}{8\pi h \Phi_0} \text{ and } \beta_{FN} = \frac{4\sqrt{2m^*}\Phi_0^{3/2}}{3\hbar q}$$

With E_C = real electric field at the contact.

The Hopping

- W:energy level, λ : distance between traps
- Time constant in a trap : $\tau = \tau_0 \text{Exp}[W/kT]$
- τ_0 is about 10^{-13} sec
- E : local electric field, q=elementary charge
- Decreasing of W by E : $q E \lambda/2$
- Probability of detrapping by sec
- $p = 2 \text{Sinh}[qE\lambda/2kT] / \tau$

Detrapping Time at 300 and 340° k

W= 0,70 eV , 58ms, 2,0 ms

W=1,00 eV , 2 hours, 50 s

W=1,30 eV , 22 years, 15 days

Influential Parameters: Materials

- Materials:
LDPE, HDPE, XLPE: distribution of traps
- Links Time , Energy W in measurement
- New materials
- Nanodielectrics
- Improvements on cables

Influential Parameters : Electric Field

- ELECTRIC FIELD :
- Less than 1-2 MV/m: polarization only
- Some MV/m to 20 MV/m : polarization and injection are apparent
- More 20-30 MV/m : only injection is apparent
- More 40 MV/m double injection

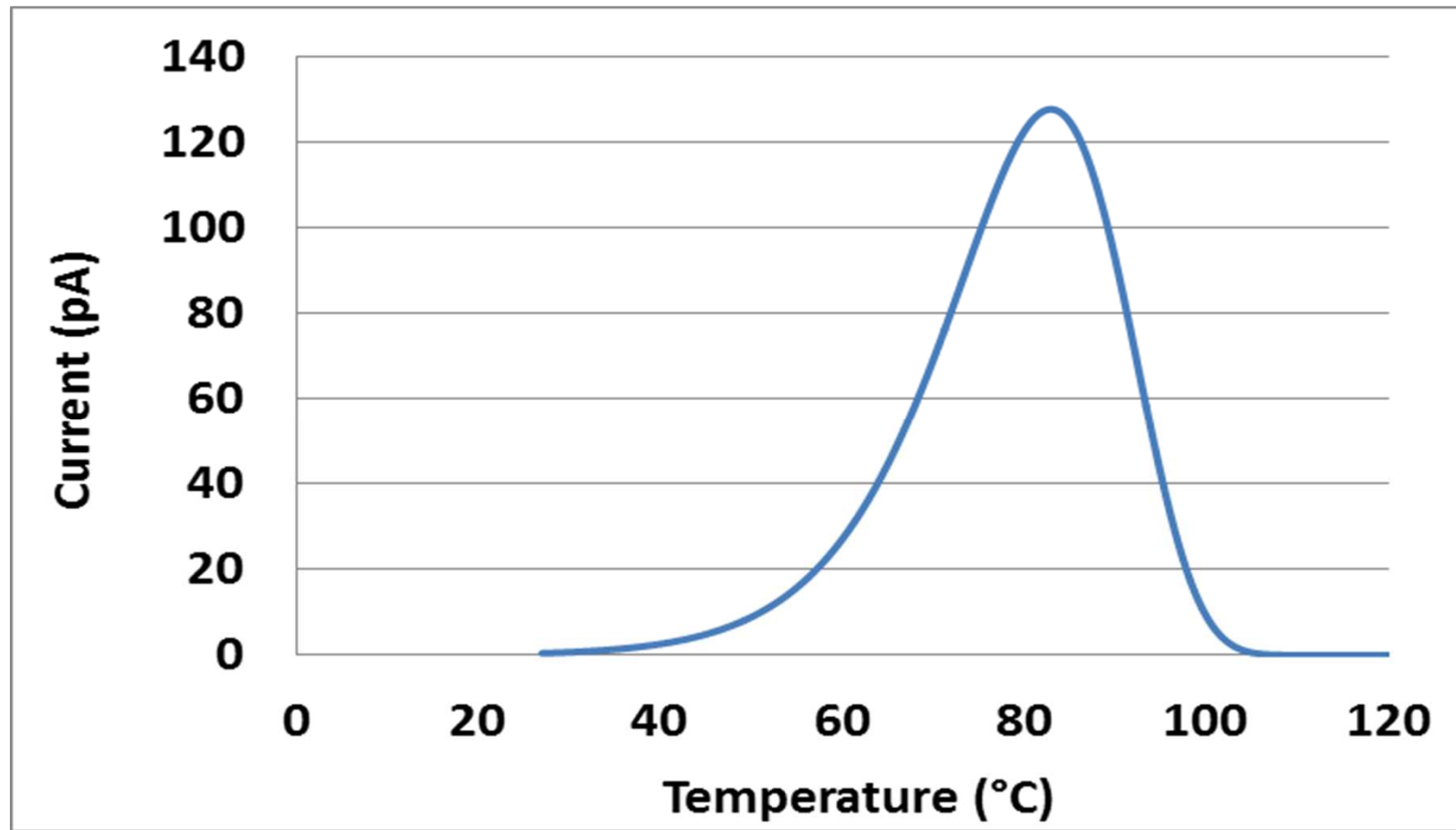


Influential Parameters: Temperature and Time

- TEMPERATURE :
- It is a parameter very active
- Polarization and injection and conduction are increased strongly after 60° C
- TIME:
- The hopping concerns the traps from 0.3 to 1.4eV giving a large scale : from ms to years !



Thermally-Stimulated Current in Pure Polarization



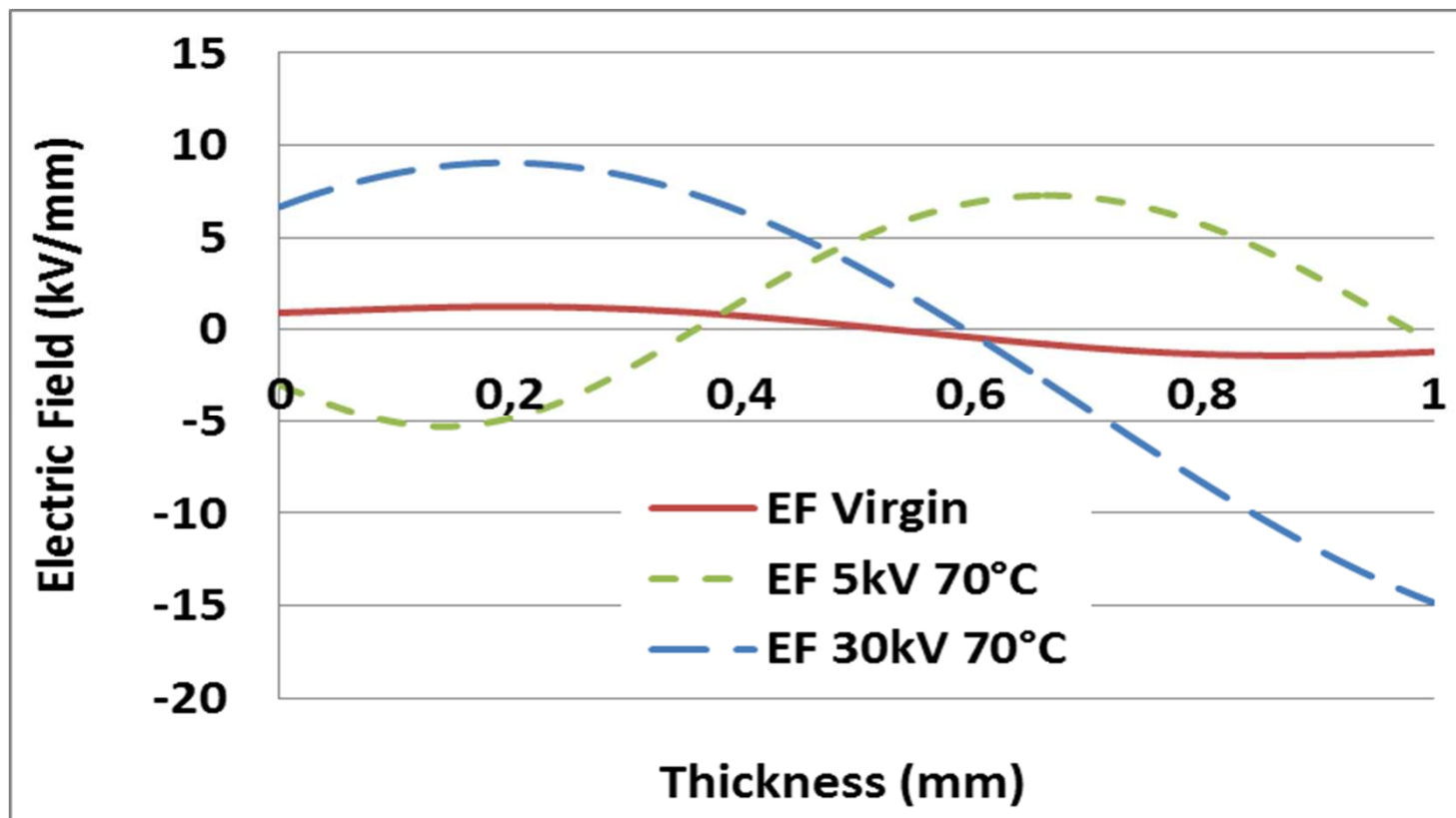
Results with pure Polarization

- Charge of Polarization, sample PEBD 200 microns thick, 30 mm diameter
- $Q_f = N_t q S \lambda \tau f \frac{2 \sinh[q \lambda E / k T]}{\tau f}$
- Thermostimulated Discharge Current:
- $I_t = -dQ/dt$, $dQ/Q = -dt/\tau$; $I_t \text{ max } T_m = 83^\circ\text{C}$
- $N_t = 3.0 \cdot 10^{23} \text{ m}^{-3}$; $Q_f = 1.0 \cdot 10^{-7} \text{ C}$
- $\lambda = 15 \text{ nm}$; $W = 1.08 \text{ eV}$

Polarization and injection

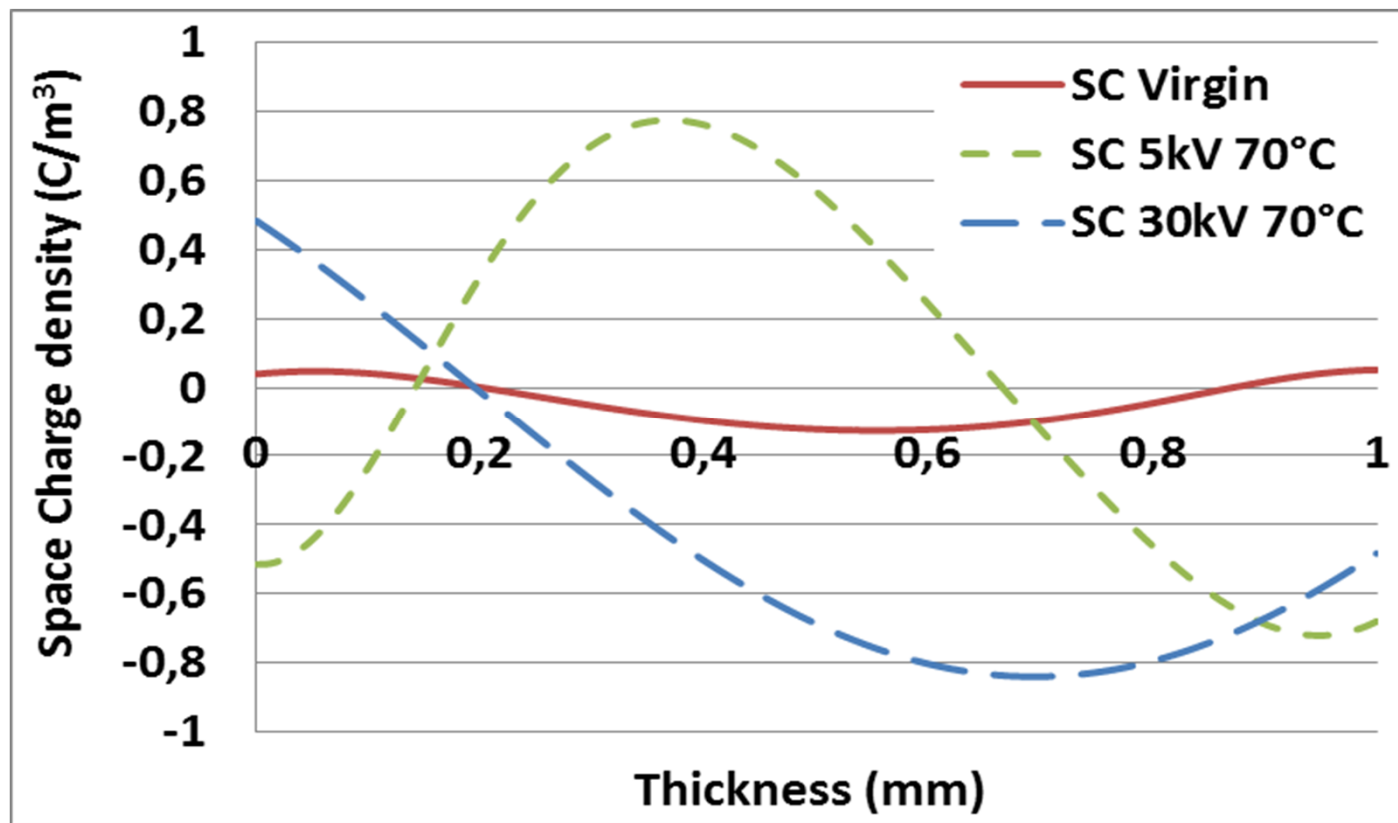
- HDPE
- 1mm thick, diameter :40 mm
- Electrodes : deposited Aluminium
- Poling : 5 and 30 MV/m at 70° C, 40 hours
- Short-circuit 30 mn; we see traps $W > 1,0 \text{ eV}$
- Electric and Space charge measurements in 3 cases : virgin, 5 MV/m, 30 MV/m

Remaining Electric Field in 3 cases





Space charges in 3 cases



Strong injection

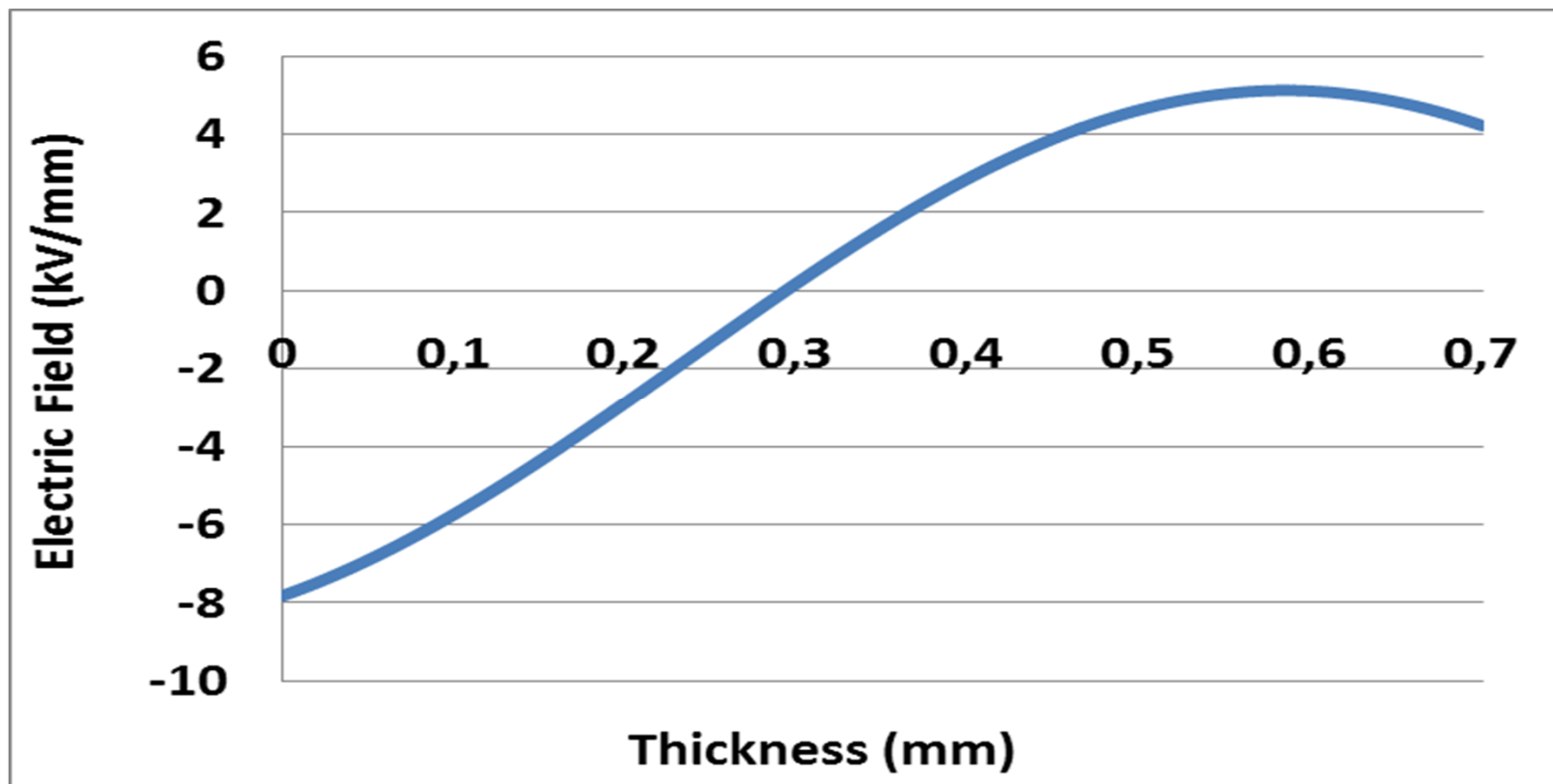
- PE sample
- 0.7 mm thick, Diameter : 40 mm
- Electrode : semiconductor

Poling 40 MV/m at 70° C, 40 hours

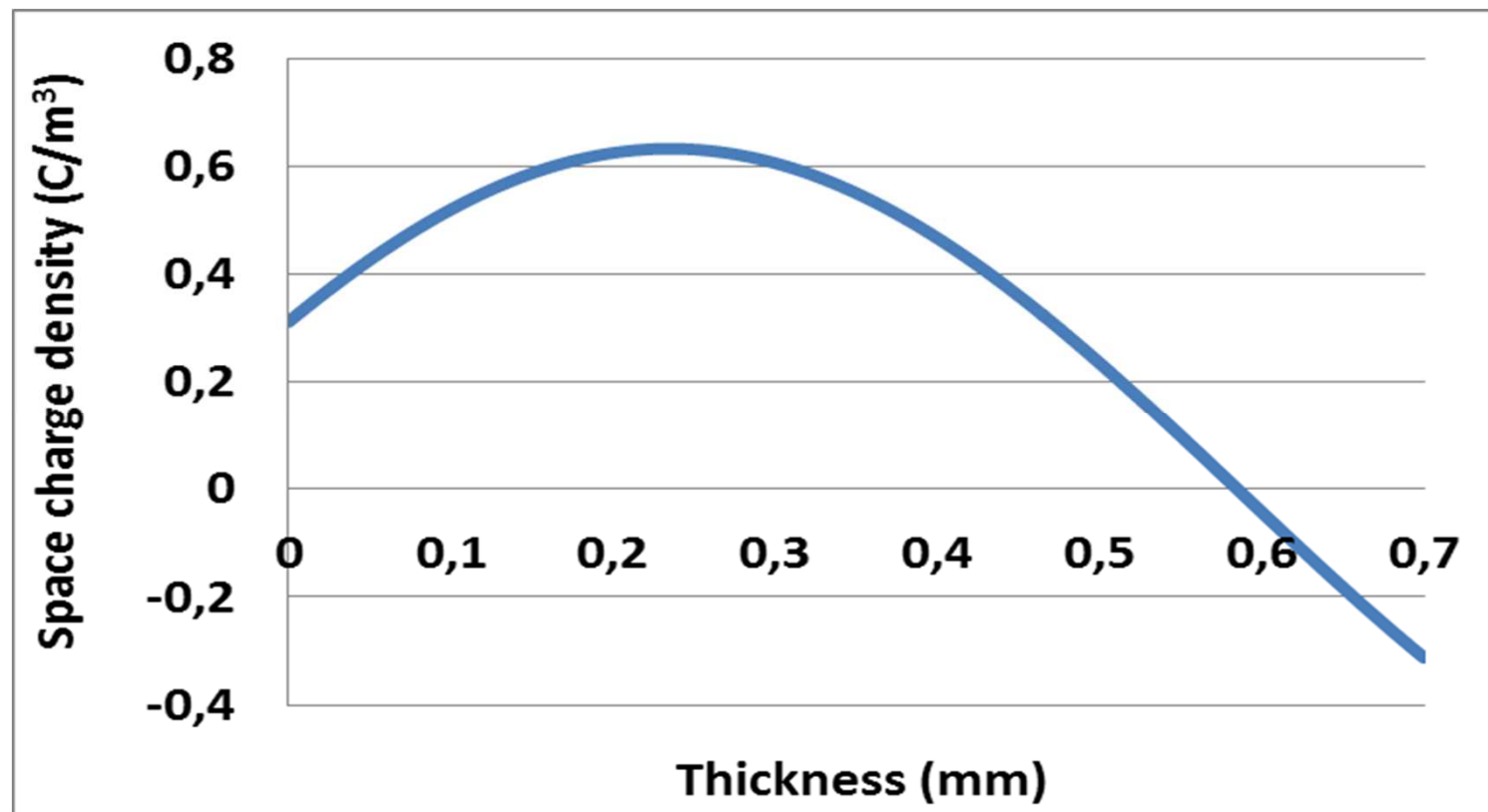
Short circuit 15 mn : traps concerns $W > 1.0$ eV

Discharged by thermostimulated current

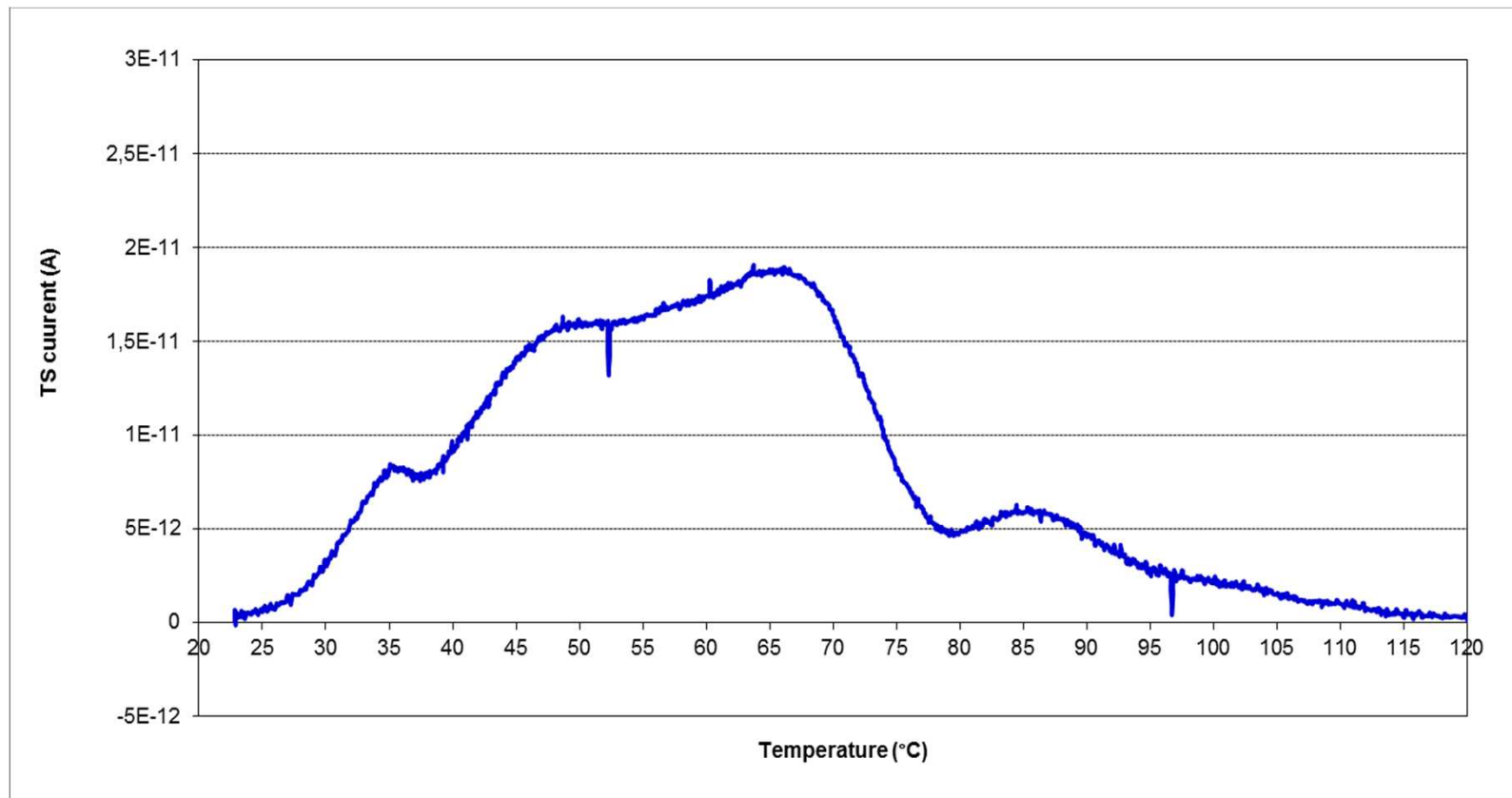
Remaining Electric Field in strong injection



Space charge in strong injection



Thermostimulated current after strong injection



Interpretation for TSC

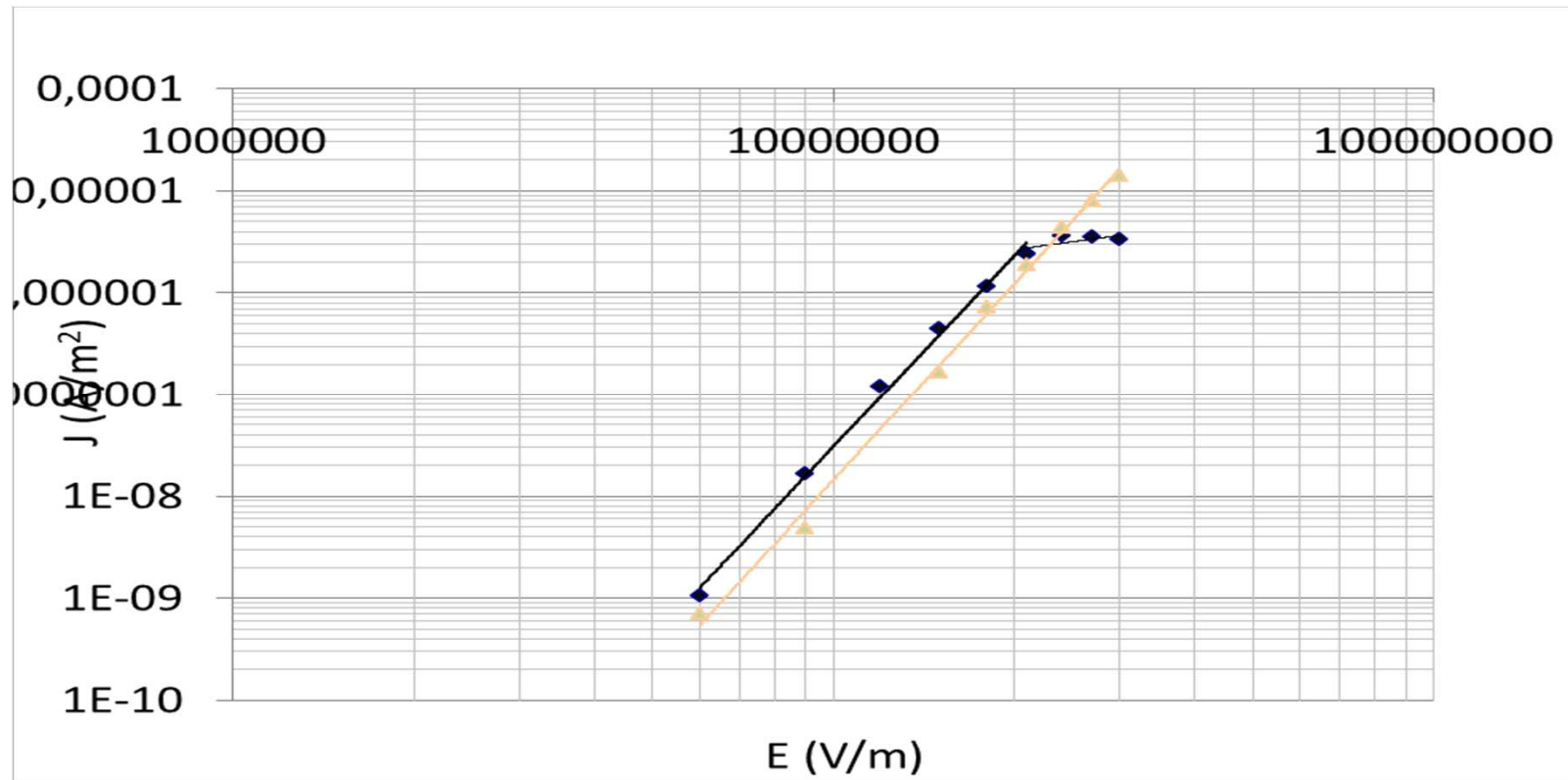
- Positive dominant charges
- Electric fields cuts practically the sample in the middle
- Two opposite currents to anode and to cathode: result gives a weak total current
- Possible reverse of this current due to each contribution to turn
- $W > 1.0 \text{ eV}$, density $< 1 \text{ C/m}^3$

Conduction

- HDPE sample
- 1 mm thick, diameter : 40 mm
- Electrode : deposited aluminium
- Voltage : from 6 to 30 MV/m
- Temperature 70° C
- Time : 2 hours for each point ($W < 1.20 \text{ eV}$)
- Current saturation at 30 MV/m



Conduction and simulation in PE



Conduction

- Interpretation by exponential distribution
- $m = T/T_c$; T_c : Temperature parameter of the distribution ; N_{tc} : Trap total density ;
- $d = d_0 \text{Exp}[-(w-w_1)/kT]$ trap density
- w_1 : first level; $d_0 = N_{tc}/kT_c$;
- N_c =total density in CB
- μ_0 = mobility in CB

Conduction

- Then the current density is given by :
- $J(V) = C1 \ C2 \ \mu_0 q N_c \text{Exp}[-w_1/kT] \ E a^{1+1/m}$
- $E a = V/L$: applied field; L : thickness; V : voltage
- $C1 = (\epsilon \text{Sin}(m\pi) / q N_t c L (1+m) m \pi)^{1/m}$
- $C2 = (2+m/1+m)^{1+1/m}$

Conduction results

- $m = T/T_c = 0.19$; $W_1 = 0.30$ eV
- $1 + 1/m = 6.3$; $N_c = 10^{26} \text{ m}^{-3}$
- $N_{tc} = 9 \cdot 10^{20} \text{ m}^{-3}$; $T = 343$ ° k
- $T_c = 1822$ ° k ; $\mu_o = 5.0 \cdot 10^{-4} \text{ m}^2/\text{V s}$
- $d_o = 3.57 \cdot 10^{40} \text{ j}^{-1} \text{ m}^{-3}$
- $0.3 \text{ eV} < W < 2.0 \text{ eV}$

CONCLUSION 1

The pure polarization inside the chains at very low electric field : Temperature only can make trapping then detrapping : N_t , λ , are evaluated

- At high electric field, the injections of two types of charges at the contact by Schottky effect facilitated by level stairs (step by step)
- Development of space charges in traps by detrapping due to Electric field and Temperature

CONCLUSION 2

- At high field > 20 MV/m: Injection of electrons
- At very high field > 40 MV/m : double injection
- Conduction associated with exponential distributions of traps in ordered zones : Ntc
- Links between time and energy W

CONCLUSION 3

- The consequences for the future:
- Elaboration of new materials which evacuate the space charge
- Be careful about thermal runaway
- This work is very complex : chemical, physical, electrical aspects
- The tight collaboration between universities and industrials



THANK YOU FOR

YOUR ATTENTION